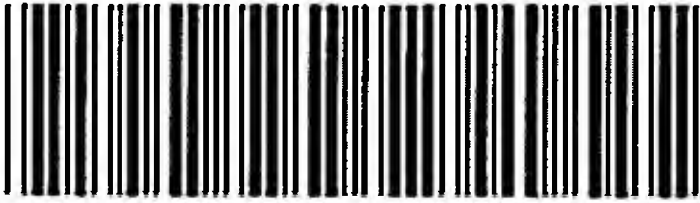


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,164	CHIEN ET AL.	
	Examiner	Art Unit	
	Naum B. Levin	2825	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT)- See search histoty printouts	2/10/2006	N L